# Spectral Fingerprints of Electron-Plasmon Coupling

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We investigate the spectroscopic fingerprints of electron-plasmon coupling in integrated (PES) and angle-resolved photoemission spectroscopy (ARPES). To account for electron-plasmon interactions at a reduced computational cost, we derived the plasmonic polaron model, an approach based on the cumulant expansion of many-body perturbation theory that circumvents the calculation of the GWself-energy. Through the plasmonic polaron model, we predict the complete spectral functions and the effects of electron-plasmon coupling for Si, Ge, GaAs, and diamond. Si, Ge, and GaAs exhibit well defined plasmonic polaron band structures, i.e., broadened replica of the valence bands redshifted by the plasmon energy. Based on these results, (i) we assign the structures of the plasmon satellite of silicon (as revealed by PES experiments) to plasmonic Van Hove singularities occurring at the L,  $\Omega$ , and X high-symmetry points and (ii) we predict the ARPES signatures of electronplasmon coupling for Si, Ge, GaAs, and diamond. Overall, the concept of plasmonic polaron bands emerges as a new paradigm for the interpretation of electronic processes in condensed matter, and the theoretical approach presented here provides a computationally affordable tool to explore its effect in a broad set of materials.

### I. INTRODUCTION

The coupling of electrons and bosonic excitations, such as phonons, magnons, and collective charge-density fluctuations (*plasmons*), may significantly alter the electronic properties of solids, triggering emergent phenomena which may not be explained within the context of a simple single-particle picture. A prototypical example is the formation of Cooper pairs,<sup>1</sup> resulting from electron-phonon coupling, and the emergence of superconductivity.<sup>2</sup> Whereas phonons have a characteristic energy in the range of 10-100 meV, the energy of *plasmons* is typically between 1 and 10 eV. The spectral signatures of electron-plasmon coupling, thus, occur at energies comparable to those of the ordinary quasiparticle states which are easily accessible in integrated (PES) and angle-resolved photoemission spectroscopy (ARPES).

Theoretical approaches for the description of electronplasmon interactions from first principles are generally based on many-body perturbation theory by combining the one-shot GW approximation<sup>3,4</sup> with the cumulant expansion approach<sup>5,6</sup> (GW+C). The cumulant expansion, formally exact for the case of an isolated coreelectron,<sup>6</sup> stems from the solution of an electron-boson coupling Hamiltonian analogous to the case of electronphonon coupling. The applicability of this method has been extended beyond the case of core satellites and its has proven useful in the description of quasiparticle dynamics,<sup>7,8</sup> and valence plasmon satellites in the *integrated* photoemission spectra of the homogeneous electron gas,<sup>9,10</sup> simple metals,<sup>11</sup> silicon,<sup>12</sup> and graphene.<sup>13,14</sup>

First-principles calculations based on the GW+cumulant approach have recently unveiled novel spectroscopic signatures of electron-plasmon coupling in the angle-resolved photoemission spectra (ARPES) of solids: the *band structures of plasmonic polarons.*<sup>15</sup> Plasmonic polarons are elementary excitations resulting

from the simultaneous excitation of an electron, and a plasmon and lead to the formation of dispersive spectral features in systems characterized by well defined plasmonic excitations (as, e.g., silicon, and transition-metal dichalcogenides) which follow closely the dispersive character of the ordinary quasiparticle band structure. In particular, the dispersive nature of plasmonic polarons leads to the formation of well-defined plasmonic polaron bands which manifest themselves as broadened replica of the ordinary quasiparticle band structure, red-shifted by the plasmon energy. The existence of plasmonic polaron bands has recently been *confirmed* by ARPES measurements of the full band structure of silicon in an energy window that extends up to 35 eV below the Fermi energy.<sup>16</sup>

In this work, we introduce the *plasmonic* polaron *model*, an approach for the computation of plasmonic polaron band structures that circumvents the calculations of the GW self-energy. Beside illustrating analytically the emergence of plasmonic polaron bands within the GW+cumulant formalism, the plasmonic polaron models allows to account for the effects of electron-plasmon coupling in the spectral properties of solids at a reduced numerical cost. We thus discuss electron-plasmon interactions in Si, GaAs, Ge, and diamond. Our results reveal that the different substructures of the plasmon satellite of silicon, as measured by XPS, may be assigned to Van Hove singularities arising from the plasmonic polaron bands taking place at the L,  $\Omega$ , and X high-symmetry points of the first Brillouin zone. For GaAs, Ge, and diamond, we predict plasmonic polaron bands in qualitative agreement with silicon, and we identify the spectral features that may guide the observation of plasmonic polaron bands in these compounds. Overall our results indicate that plasmonic polaron bands provide a novel concept that may prove generally applicable in the interpretation of the integrated and angle-resolved spectral properties of solids.

### II. PLASMONIC POLARON MODEL

In the following, we derive an approach to predict the band structures of plasmonic polarons at the numerical cost of a band structure calculation, circumventing the explicit calculation of the GW self-energy. The cumulant expansion for the single-particle Green function<sup>6,9–14,17,18</sup> provides an ideal framework for the description of electron-plasmon interactions in solids. In particular, the starting point for the following discussion is provided by the derivation of the GW+cumulant approach reported in Ref. 11 (referred to as  $GW + C_{AHK}$ hereafter). If one neglects rare events in which multiple plasmons are emitted simultaneously with the excitation of a photo-hole, the GW+C<sub>AHK</sub> spectral function can be expressed as:<sup>11</sup>

$$A(\mathbf{k},\omega) = \sum_{n} [A_{n}^{\mathrm{QP}}(\mathbf{k},\omega) + A_{n}^{\mathrm{QP}}(\mathbf{k},\omega) * A_{n}^{\mathrm{C}}(\mathbf{k},\omega)].$$
(1)

The first term in Eq. (1) accounts for the spectral signatures of quasiparticle excitations (i.e., in absence plasmon emission) and is defined as:

$$A_n^{\rm QP}(\mathbf{k},\omega) = \frac{1}{\pi} \frac{\Gamma_{n\mathbf{k}}(\omega)}{[\omega - \varepsilon_{n\mathbf{k}} - \Delta\Sigma_{n\mathbf{k}}(\varepsilon_{n\mathbf{k}})]^2 + [\Gamma_{n\mathbf{k}}(\omega)]^2},$$
<sup>(2)</sup>

where  $\Delta \Sigma_{n\mathbf{k}}$  denotes the  $G_0 W_0$  quasiparticle correction<sup>3,4</sup> to the Kohn-Sham eigenvalues<sup>19,20</sup>  $\varepsilon_{n\mathbf{k}}$ , and  $\tau_{n\mathbf{k}} \equiv 1/\Gamma_{n\mathbf{k}}$  the quasiparticle lifetime. Here and in the following we adopt Hartree atomic units. As discussed in Ref. 15, the convolution product in the second term of Eq. (1) introduces novel dispersive features in the spectral function, which account for events in which a photo-hole and a plasmon are excited simultaneously. The term  $A_n^C$  is defined as:<sup>11</sup>

$$A_n^{\rm C}(\mathbf{k},\omega) = \frac{\beta_{n\mathbf{k}}(\omega) - \beta_{n\mathbf{k}}(\varepsilon_{n\mathbf{k}}) - (\omega - \varepsilon_{n\mathbf{k}}) \frac{\partial \beta_{n\mathbf{k}}}{\partial \omega} \Big|_{\varepsilon_{n\mathbf{k}}}}{(\omega - \varepsilon_{n\mathbf{k}})^2},$$
(3)

where  $\beta_{n\mathbf{k}}(\omega) = \pi^{-1} \mathrm{Im} \Sigma_{n\mathbf{k}} (\varepsilon_{n\mathbf{k}} - \omega) \theta(\mu - \omega).$ 

To simplify the evaluation of Eq. (1), we notice that the self-energy of systems characterized by well-defined plasmon resonances - as, e.g., simple metals<sup>11</sup> (Al and Na) and semiconductors<sup>21</sup> (Si and GaAs) – exhibits an imaginary part with a large plasmon peak at  $\omega = \varepsilon_{n\mathbf{k}} - \Omega_p$ , where  $\Omega_p$  is the plasmon energy. The plasmon peak in  $Im\Sigma$  stems directly from the plasmonic resonance of  $\mathrm{Im}\epsilon^{-1}(\omega)$ , with  $\epsilon$  being the dielectric function in the random-phase approximation (RPA). Therefore, the second term of Eq. (1) may be simplified by assuming Im $\Sigma_{n\mathbf{k}} \simeq \lambda_{n\mathbf{k}} L(\omega)$ , where  $\lambda_{n\mathbf{k}}$  is a constant and L a normalized Lorentzian function centered at  $\omega = \varepsilon_{n\mathbf{k}} - \Omega_p$ , that is:  $L(\omega) = (\gamma/\pi)/[(\omega - \varepsilon_{n\mathbf{k}} + \Omega_p)^2 + \gamma^2]$ . The ansatz introduced above for  $\text{Im}\Sigma$  is an oversimplification of the structures of the self-energy that, as demonstrated below, suffices to reproduce the essential experimental



Figure 1. Angle-resolved spectral function of Silicon for momenta along the  $\Gamma$ -X direction evaluated from (a) the plasmonic polaron model [Eq. (5)] and (b) converged  $SGW + C_{AHK}$  calculations from Ref. 15. The vertical arrow indicates the plasmon energy  $\Omega_p$  of silicon. The *bare* PBE band structure and its shifted plasmonic polaron replica are shown in blue.

spectral features arising from the electron-plasmon interaction.

The Lorentzian *ansatz* for Im $\Sigma$  can be derived within the framework of the ordinary plasmon-pole approximation<sup>4,22–28</sup> for *GW* calculations by considering non-dispersive bands and non-dispersive plasmons.

If the full-width at half maximum (FWHM)  $\gamma$  is assumed to be sufficiently small ( $\gamma \ll |\varepsilon_{n\mathbf{k}} - \Omega_p|$ ) one may retain only the first term in the numerator of Eq. (3), which simplifies to:

$$A_n^{\rm C}(\mathbf{k},\omega) = \frac{\beta_{n\mathbf{k}}(\omega)}{(\omega - \varepsilon_{n\mathbf{k}})^2} \simeq \frac{\lambda_{n\mathbf{k}}}{\pi\Omega_p^2} L(\varepsilon_{n\mathbf{k}} - \omega).$$
(4)

The convolution product in Eq. (1) can be approximated using Eq. (4) and the spectral function reduces to:

$$A(\mathbf{k},\omega) \simeq \sum_{n} \left[ A_n^{\rm QP}(\mathbf{k},\omega) + \frac{\lambda_{n\mathbf{k}}}{\pi\Omega_p^2} A_n^{\rm QP}(\mathbf{k},\omega+\Omega_p) \right].$$
(5)

Equation (5) – the central equation of the plasmonic polaron model – illustrates the emergence of band structure replicas as a result of electron-plasmon interactions. The resulting additional spectral features are the band structures of plasmonic polarons – copies of the ordinary quasiparticle bands red-shifted by the plasmon energy  $\Omega_p$ . These bands, which follow closely the momentum dependence of the quasiparticle energies, reveal the dispersive nature of plasmonic polarons.

In Eq. (5), the prefactor  $\lambda_{n\mathbf{k}}/\pi\Omega_p^2$  determines the relative spectral weight of the plasmonic polaron features with respect to the quasiparticle peaks, and it may be related to the quasiparticle weight  $Z_{n\mathbf{k}}$ . In practice, the quasiparticle part of the spectral function is related to



Figure 2. (a) Spectral function of silicon determined from the plasmonic polaron model [Eq. (5)]. The plasmonic polaron intensity has been magnified by a factor of 3 to enhance visibility. (b) Experimental (integrated) x-ray photoemission spectrum (XPS) of silicon reproduced from Ref. 18. (c) Quasiparticle and plasmonic polaron (magnified by a factor of 2) density of states (DOS). Different peaks and shoulders of the plasmonic polaron resonance in the XPS spectrum are attributed to plasmonic Van Hove singularities occurring on different high-symmetry lines in the Brillouin zone (red circles).

the quasiparticle weight through  $\int_{-\infty}^{\mu} A_{n\mathbf{k}}^{\text{QP}}(\omega) d\omega = Z_{n\mathbf{k}}$ . Similarly, making use of Eq. (4) and of the normalization of  $L(\omega)$  one can write:

$$\int_{-\infty}^{\mu} [A_n^{\rm QP}(\mathbf{k},\omega) * A_n^{\rm C}(\mathbf{k},\omega)] d\omega = \frac{\lambda_{n\mathbf{k}}}{\pi \Omega_p^2} Z_{n\mathbf{k}}.$$
 (6)

Requiring the normalization of the spectral function (that is,  $\int_{-\infty}^{\mu} A_{n\mathbf{k}}(\omega) = 1$ ) it is possible to express  $\lambda_{n\mathbf{k}}$  explicitly in terms of  $\Omega_p$  and  $Z_{n\mathbf{k}}$ :<sup>29</sup>

$$\lambda_{n\mathbf{k}} = \pi \Omega_p^2 \frac{1 - Z_{n\mathbf{k}}}{Z_{n\mathbf{k}}}.$$
(7)

To further simplify the calculation of the plasmonic polaron band structures, we neglect the quasiparticle correction to the Kohn-Sham eigenvalues (i.e.,  $\Delta \Sigma_{n\mathbf{k}} = 0$ ) in Eq. (2), and we introduce a simple analytical model for the quasiparticle lifetime. According to Fermi liquid theory, the inverse lifetime of quasiparticle states close to the Fermi energy increases quadratically with their energy , that is  $\tau_{n\mathbf{k}}^{-1} \propto (\varepsilon_{n\mathbf{k}} - \mu)^2$ . Here we consider semiconductors, whereby  $\text{Im}\Sigma(\omega) = 0$  for energies in the range  $\omega \in [\mu - E_g, \mu], E_g$  being the quasiparticle band gap, owing to the absence of (electronic) decay channels that may induce a de-excitation of the photohole. We combine these two ideas to define a simplified model for the electronic lifetimes of semiconductors. Henceforth, we assume a quadratic dependence of the quasiparticle lifetimes on the frequency (relative to the Fermi energy), in the form:  $\Gamma(\omega) = \eta + \alpha(\omega + E_g)^2 \theta(\mu - E_g - \omega)$ . In short,  $\eta = 0.05$  eV is introduced to avoid divergences close to the Fermi energy, whereas the term  $E_{\rm g}$  ensures that the inverse lifetime of states in the energy window  $\omega \in [\mu - E_{\rm g}, \mu]$  is negligible due to the absence of decay channels (phonon-assisted decay processes are neglected here). The parameter  $\alpha$  is determined by imposing the equality between the integrated area of the broadening model defined above and the area underlying the imaginary part of the self-energy, which coincides with  $\lambda_{n\mathbf{k}}$ . In other words, we require  $\int_{\overline{\omega}}^{\mu} \Gamma(\omega) d\omega = \int_{\overline{\omega}}^{\mu} \text{Im} \Sigma_{n\mathbf{k}}(\omega) d\omega =$  $\lambda_{n\mathbf{k}}$ , where  $\overline{\omega}$  denotes the energy such that  $\text{Im} \Sigma_{n\mathbf{k}}(\omega) \simeq 0$ for  $\omega < \overline{\omega}$  [in the following,  $\overline{\omega} = 2(\varepsilon_{n\mathbf{k}} - \Omega_p)$ ]. Alternative broadening function models for  $\Gamma$  may be employed, however the precise choice for  $\Gamma$  does not alter the qualitative features of the plasmonic polaron band structures determined through Eq. (5).

In summary, Eqs. (2) and (5) define a simple general procedure for predicting the plasmonic polaron band structures of systems characterized by well defined plasmonic excitations, avoiding the explicit calculation of the GW self-energy. The resulting model requires knowledge of a few parameters which, for semiconductors, may easily be inferred from experiment and/or first-principles calculations: the plasmon energy  $\Omega_p$ , the quasiparticle weight  $Z_{n\mathbf{k}}$ , and the quasiparticle band gap  $E_{g}$ . For spbonded semiconductors typically  $0.7 < Z_{n\mathbf{k}} < 0.9$ . In the following, we assume  $Z_{n\mathbf{k}} \simeq 0.8$ , as, e.g., for bulk Si and Ge. To further reduce the number of external parameters, we obtain the plasmon energy  $\Omega_p$  from a simple model for the frequency-dependent dielectric function of semiconductors:<sup>30</sup>  $\Omega_p^2 = \omega_p^2 + E_g^2$ , where  $\omega_p$  is the homogeneous electron gas plasma frequency at the valence



Figure 3. Spectral function of (a) Ge and (c) GaAs determined from the plasmonic polaron model [Eq. (5)]. The plasmonic polaron intensity has been magnified by a factor of 3 to enhance visibility.  $\alpha$ ,  $\beta$ , and  $\gamma$  denote regions characterized by low density of states due to the absence of plasmonic polarons and quasiparticle states. Panel (b) and (d): quasiparticle and plasmonic polaron DOS of Ge and GaAs.

electron density<sup>30</sup> and  $E_{\rm g}$  the quasiparticle band gap. In the following, we consider the experimental value for the quasiparticle band gap  $E_{\rm g}$ . Once the parameters  $\Omega_p$ ,  $E_{\rm g}$ , and Z are given, the evaluation of Eq. (5) can be performed through a simple band-structure calculation. In the following, all calculations are performed in a planewave basis within the Quantum Espresso code.<sup>31,32</sup>

Before moving on to discuss electron-plasmon interactions in semiconductors, we briefly summarize the approximations employed in the plasmonic polaron model and we comment on their validity. The only assumptions used until this point are that (i) the imaginary part of the self-energy can be approximated by a sharp pole at the plasmon energy and (ii) the photo-emission process can be described within the *sudden approximation*.

The assumption (i) is based on the fact that systems characterized by plasmonic excitations typically exhibit a well defined resonance in the imaginary part of the inverse dielectric function  $\epsilon$  (owing to its relation to the electron energy loss function<sup>33</sup>) which introduces a corresponding plasmonic resonance in  $\text{Im}\Sigma$  via the relation  $\text{Im}\Sigma = \text{Im}[\epsilon^{-1}v]G$ . This approximation is thus justified for systems in which the plasmon-pole approximation yields a reasonable description of the inverse dielectric matrix. The plasmon energy dispersion, neglected within approximation (i), would introduce an additional broadening of the self-energy but it is not expected to alter the qualitative spectral features obtained from the model. The approximation (ii) in practice corresponds to neglecting extrinsic effects to the photoemis-sion  $process^{12,34-36}$ . Extrinsic effects, which account for the interactions between the photoelectron and the system after emission, are expected to introduce an additional broadening of the plasmonic polaron features and a renormalization of their intensity<sup>12,18</sup>. Additionally, in the following we estimate the plasmon energies from a simplified dielectric function model for semiconductors which assumes that collective charge density fluctuations involve the entirety of the valence electrons and that electronic states are sufficiently delocalized<sup>37,38</sup> (conditions obeyed by *sp*-bonded systems as those considered here). For *d*- and *f*-electron systems, where these conditions may not apply, it would be more appropriate to employ plasmon energies derived either from experiment, from first-principles calculations of the energy-loss function in the random-phase approximation, or from more elaborate dielectric function models.

## III. PLASMONIC POLARONS AND PLASMONIC VAN HOVE SINGULARITIES

As a first step, we validate the plasmonic polaron model by comparing the spectral function of silicon obtained from Eq. (5) with accurate first-principles calculations based on the SternheimerGW+cumulant approach<sup>11,15,21,39</sup> (SGW +  $C_{AHK}$ ). In short, SGW provides an accurate reference method for the calculation of the full spectral function. In particular, in SGW (i) summations over empty states are avoided by computing the screened Coulomb interaction W and Green's function through the iterative solution of the Sternheimer equation and (ii) beside the random-phase approximation (RPA) there are no further approximations (as, e.g., the plasmon-pole model) involved in the computation of the dielectric function. More details on the theoretical and numerical aspects underlying the Sternheimer-GWapproach can be found elsewhere.<sup>21,39,40</sup> In Fig. 1, we report the angle-resolved spectral function of Silicon for momenta within the first Brillouin zone along the  $\Gamma$ -X high-symmetry line as obtained from (a) the plasmonic polaron model [Eq. (5)] and (b) the  $SGW + C_{AHK}$  approach. The PBE band structure of silicon and its plasmonic polaron replica (red-shifted by the plasmon energy  $\Omega_p$ ) are superimposed as a continuous blue line for comparison. Overall, as illustrated in Fig. 1, the proposed plasmonic polaron model allows us to reproduce the qualitative features of  $SGW + C_{AHK}$  approach at the cost of a band-structure calculation. Based on this finding, we now move on to discuss the full spectral function of Si, GaAs, Ge, and diamond and the spectral fingerprints of plasmonic polaron excitations in these compounds.

In Fig. 2 we report (a) the full spectral function of silicon evaluated within the plasmonic polaron model and (c) the corresponding density of states (DOS). The plasmonic polaron DOS has been calculated by ignoring the frequency dependent component of the broadening function  $(\alpha = 0)$  to emphasize the structure arising from the different Van Hove singularities. To approximately account for the different cross-section effects, the DOS has been obtained as a weighted sum of the s-orbital and *p*-orbital projected-DOS, with weights given by the relative cross-section of the s and p states at a phonon energy of  $800 \text{ eV}^{41}$ . The plasmonic polaron DOS has been magnified by a factor of two to enhance the visibility on the same scale of the quasiparticle spectral features. The experimental integrated x-ray photoemission spectrum (XPS) reproduced from Ref. 18 is reported for comparison in Fig. 2 (b). The spectral function exhibits a set of bright quasiparticle bands for binding energies in the range of 0 to 12 eV. These bands arise from the first term of Eq. (5) and define the ordinary band structure of silicon. Their intensity is proportional to the emission rate of a photoelectron in absence of plasmonic excitations. In addition to the ordinary quasiparticle band structure, electron-plasmon coupling introduces additional dispersive spectral features in the angle-resolved spectrum. These spectral features, which manifest themselves as broadened replica of the valence band structure, reveal the excitation of plasmonic polarons, i.e., elementary excitation in which the energy of the absorbed photon contributes to the emission of a photoelectron and the excitation of a plasmon with energy  $\sim \Omega_p$ .

Our previous work<sup>15</sup> revealed that, similarly to ordinary quasiparticle bands, also plasmonic polaron band structures may lead to the formation of Van Hove singularities in the density of states (DOS). For quasiparticle bands, the density of states J may be expressed as:

$$J(\omega) = \frac{1}{4\pi^3} \sum_{n} \int dS_{\mathbf{k}} \frac{1}{|\nabla_{\mathbf{k}} \varepsilon_{n\mathbf{k}}|}$$
(8)

where  $S_{\mathbf{k}}$  denotes the surface  $\varepsilon_{n\mathbf{k}} = \text{constant.}$  Equation (8) indicates that whenever the first momentum derivative of the quasiparticle bands  $\varepsilon_{n\mathbf{k}}$  vanishes (that is,  $|\nabla_{\mathbf{k}}\varepsilon_{n\mathbf{k}}| = 0$ ) the density of states exhibits sharp resonances, known as Van Hove singularities.<sup>42</sup> Consequently, the structures that characterize the DOS for binding energies between 0 and 12 eV may be attributed to specific high-symmetry points of the first BZ, whereby quasiparticle bands are flat, and thus their derivative vanishes.



Figure 4. Spectral function (a) and DOS (b) of diamond determined from the plasmonic polaron model [Eq. (5)].

The concept of Van Hove singularities may easily be generalized to the case of plasmonic polarons. In this case, however, we do not expect the emergence of sharp resonances owing to the large broadening characteristic of plasmonic polaron excitations. For silicon the XPS measurements at binding energies between 15 to 30 eV reveal a broad plasmon satellite characterized by a substructure of peaks and shoulders. These structure can be assigned to Van Hove singularities that arise from the plasmonic polaron band structures.

Having established a numerically efficient procedure to compute the plasmonic polaron contribution to the full spectral function, we can now proceed to assign the structures in the XPS plasmon satellite of silicon to highsymmetry points in the first BZ. As illustrated in Fig. 2, the two main peaks that characterize the plasmon satellite at 20 and 24 eV are Van Hove singularities resulting from a flattening of the plasmonic polaron bands at X and  $\Omega$  (the middle point on the W-L high-symmetry line), respectively. Similarly, the two shoulders at 18 and 26 eV originate from the L point. The DOS of plasmonic polarons reported in Fig. 2 (c) further validates this analysis, illustrating that the Van Hove singularities of the plasmonic polaron bands leads to spectral features in excellent agreement with the experimental reference data. These results provide a simple rationale to unravel the complex features of the plasmon satellites in the integrated photoemission measurements of solids. In particular, plasmon satellites can be attributed to plasmonic Van Hove singularities and their substructures arise from the flattening of the plasmonic polaron bands at different high-symmetry points in the Brillouin zone.

We now move on to discuss the plasmonic polaron band structures of Ge and GaAs. In Fig. 3 we report the full spectral function of Ge (a) and GaAs (c) determined from the plasmonic polaron model and the corresponding DOS in panels (b) and (d), respectively. The spectral functions of Ge and GaAs exhibit similar qualitative features to Si. For binding energies up to 15 eV below the Fermi energy, the spectrum is characterized by the ordinary quasiparticle band structure. For binding energies larger than 15 eV, the spectral function is dominated by the plasmonic polaron bands. These bands are expected to provide a dominant contribution to the density of states in this energy range. Overall for Si, Ge, and GaAs, the broadening of the plasmonic polaron bands may obstruct the experimental observation of the individual bands. However, based on the results presented in Figs. 2 and 3, we identify general patterns that may drive the experimental observation of plasmonic polaron bands. In particular, Si, Ge, and GaAs manifest a depletion of density of states around the  $\Gamma$  point for binding energies between 20 and 30 eV. As illustrated in Fig. 3, this leads to the emergence of a diamond-shaped structure (denoted as  $\gamma$  in Fig. 3) in ARPES measurements. The low-intensity region  $\gamma$  can be attributed to the gap between the first three degenerate plasmonic polaron bands (that is, the plasmonic replica of the three top-most quasiparticle bands) at the  $\Gamma$  point and the fourth plasmonic polaron band. Similarly, we observe a lowering of spectral intensity around W and X (denoted as  $\alpha$  and  $\beta$  in Fig. 3) for binding energies between 11 and 18 eV below the Fermi energy. In this case, the  $\alpha$  and  $\beta$  regions stem from the gap between the lowest quasiparticle band and the first plasmonic polaron band.

Our calculations for the plasmonic polarons DOS [Fig. 3 (b) and (d)] indicates that, similarly to the quasiparticle DOS, plasmonic polarons leads to the formation of well defined Van Hove singularities. We thus predict that XPS measurements of Ge (GaAs) should reveal a plasmon satellite characterized by at least three different structures at binding energies of 18.5, 23.0, and 26.1 eV (18.1, 22.0, and 26.3 eV). As in the case of silicon, we attributed these structures to the flattening of the plasmonic polaron bands at different high-symmetry points of the Brillouin zone (the X,  $\Omega$ , and L points) as illustrated in panels (b) and (d) of Fig. 3.

As a last example, we consider the case of diamond. The electronic properties of diamond are qualitatively different from those of the semiconductors discussed above. In particular, diamond is wide gap insulator  $(E_{\rm g} \simeq 5.5 \text{ eV})$ , its bands are more dispersive than Si, Ge, and GaAs, and it has a larger plasmon energy  $\Omega_p \simeq 22.5$  eV. These features are expected to affect considerably the band structures of plasmonic polarons. An inspection of the full spectral function [Fig. 4 (a)] reveals that the plasmonic polaron bands emerge at larger binding energies as compared to the other compounds, owing to the larger plasmon energy  $\Omega_p$ . Because of the shorter lifetime of plasmonic polarons at these binding energies, however, their spectral signatures appear broader and less intense. For the case of diamond, electron-plasmon interactions are thus expected to introduce low intensity spectral features that might be difficult to reveal in ARPES measurements. However, a possible evidence of electron-plasmon coupling might arise in the form of an X-shaped resonance at the bottom of the valence band [denoted as  $\gamma$  in Fig. 4 (a)] which results from the merging of the lowest-energy valence band and the highest-energy plasmonic polaron band at the  $\Gamma$  point. Similarly, the large bandwidth of quasiparticle and plasmonic polaron bands of diamonds leads to less pronounced Van Hove singularities as compared to silicon and GaAs [Fig. 4 (b)]. Correspondingly, the plasmon satellite is unlikely to exhibit substructures that may be attributed to Van Hove singularities occurring at different points in the Brillouin zone. In particular, the broadening is expected to wash out and merge the two resonances at 34.2 and 38.2 eV indicated in Fig. 4 (b).

### IV. CONCLUSIONS

In summary, we presented a study of the spectroscopic signatures of electronic-plasmon coupling in integrated and angle-resolved photoemission experiments on tetrahedral semiconductors. Based on the cumulant expansion for the spectral function, we derived the plasmonic polaron model, a simplified approach for the calculation of the band structures of plasmonic polarons in solids. This model, that does not require the explicit computation of the GW self-energy, allows us to predict the full spectral function of solids at the numerical cost of a band structure calculation. Our results unveil the effects of electron-plasmon coupling for Si, Ge, GaAs, and diamond. Si, Ge, and GaAs exhibit reasonably well defined plasmonic polaron band structures, that manifest themselves as broadened replica of the valence bands redshifted by the plasmon energy, whereas for diamond plasmonic polarons spectral features are suppressed by short lifetime effects. Additionally, this study reveals that the different structures that characterize the plasmon satellite of silicon may be attributed to *plasmonic Van Hove* singularities occurring at specific high-symmetry points in the Brillouin zone. This indicates that the dispersive nature of plasmonic polarons may be revealed already in integrated photoemission experiments. Finally, our analysis provides clear guidelines for identifying the spectral signatures of plasmonic polarons in ARPES. In particular, for Si, Ge, and GaAs, plasmonic polaron bands should lead to low-intensity regions in the spectral function around the X and  $\Gamma$  points for binding energies around 15 and 25 eV, respectively.

Overall, plasmonic polaron bands emerge as an important new concept for the interpretation of integrated and angle-resolved photoemission experiments. These findings calls for renewed experimental efforts along the lines of Ref. 16 for silicon. The work presented here provides a simple predictive tool that may prove useful to unravel the complexity of photoemission spectra for a broad class of materials (including, e.g., semiconductors, metals, and d/f-electron systems), and to advance our understanding of elementary electronic excitations in condensed matter.

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